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## EMC –

### **Utrustning och metoder för mätning av radiostörningar och immunitet – Del 4-3: Onoggrannhet vid EMC-mätningar och gränsvärdesmodellering – Statistiska överväganden vid bestämning av EMC-överensstämmelse för massproducerade produkter**

*Specification for radio disturbance and immunity measuring apparatus and methods –*

*Part 4-3: Uncertainties, statistics and limit modelling –*

*Statistical considerations in the determination of EMC compliance of mass-produced products*

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### *Standarder underlättar utvecklingen och höjer elsäkerheten*

Det finns många fördelar med att ha gemensamma tekniska regler för bl a mätning, säkerhet och provning och för utförande, skötsel och dokumentation av elprodukter och elanläggningar.

Genom att utforma sådana standarder blir säkerhetsfordringar tydliga och utvecklingskostnaderna rimliga samtidigt som marknadens acceptans för produkten eller tjänsten ökar.

Många standarder inom elområdet beskriver tekniska lösningar och metoder som åstadkommer den elsäkerhet som föreskrivs av svenska myndigheter och av EU.

### *SEK är Sveriges röst i standardiseringsarbetet inom elområdet*

SEK Svensk Elstandard svarar för standardiseringen inom elområdet i Sverige och samordnar svensk medverkan i internationell och europeisk standardisering. SEK är en ideell organisation med frivilligt deltagande från svenska myndigheter, företag och organisationer som vill medverka till och påverka utformningen av tekniska regler inom elektrotekniken.

SEK samordnar svenska intressenters medverkan i SEKs tekniska kommittéer och stödjer svenska experters medverkan i internationella och europeiska projekt.

### *Stora delar av arbetet sker internationellt*

Utformningen av standarder sker i allt väsentligt i internationellt och europeiskt samarbete. SEK är svensk nationalkommitté av International Electrotechnical Commission (IEC) och Comité Européen de Normalisation Electrotechnique (CENELEC).

Standardiseringsarbetet inom SEK är organiserat i referensgrupper bestående av ett antal tekniska kommittéer som speglar hur arbetet inom IEC och CENELEC är organiserat.

Arbetet i de tekniska kommittéerna är öppet för alla svenska organisationer, företag, institutioner, myndigheter och statliga verk. Den årliga avgiften för deltagandet och intäkter från försäljning finansierar SEKs standardiseringsverksamhet och medlemsavgift till IEC och CENELEC.

### *Var med och påverka!*

Den som deltar i SEKs tekniska kommittéarbete har möjlighet att påverka framtida standarder och får tidig tillgång till information och dokumentation om utvecklingen inom sitt teknikområde. Arbetet och kontakterna med kollegor, kunder och konkurrenter kan gynnsamt påverka enskilda företags affärsutveckling och bidrar till deltagarnas egen kompetensutveckling.

Du som vill dra nytta av dessa möjligheter är välkommen att kontakta SEKs kansli för mer information.

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# TECHNICAL REPORT

INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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**Specification for radio disturbance and immunity measuring apparatus and methods –**

**Part 4-3: Uncertainties, statistics and limit modelling – Statistical considerations in the determination of EMC compliance of mass-produced products**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

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### **SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –**

#### **Part 4-3: Uncertainties, statistics and limit modelling – Statistical considerations in the determination of EMC compliance of mass-produced products**

### FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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The main task of IEC technical committees is to prepare International Standards. However, a technical committee may propose the publication of a technical report when it has collected data of a different kind from that which is normally published as an International Standard, for example "state of the art".

CISPR 16-4-3, which is a technical report, has been prepared by CISPR subcommittee A: Radio interference measurements and statistical methods.

This second edition of CISPR 16-4-3 cancels and replaces the first edition published in 2003 and constitutes a technical revision. It includes a new mathematical approach for the application of the 80%/80% rule, based on a method involving an additional acceptance limit. The mathematical basis for this new method is also provided. Furthermore, an additional test approach, based on the non-central *t*-distribution and using frequency sub-ranges has been added as well, along with a description of the properties of all methods which are available at this point in time.

This consolidated version of CISPR 16-4-3 consists of the second edition (2004) [documents CISPR/A/491/DTR + CISPR/A/492/DTR and CISPR/A/507/RVC + CISPR/A/508/RVC] and its amendment 1 (2006) [documents CISPR/A/666/DTR and CISPR/A/691/RVC].

The technical content is therefore identical to the base edition and its amendment and has been prepared for user convenience.

It bears the edition number 2.1.

A vertical line in the margin shows where the base publication has been modified by amendment 1.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of the base publication and its amendments will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

## **SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –**

### **Part 4-3: Uncertainties, statistics and limit modelling – Statistical considerations in the determination of EMC compliance of mass-produced products**

## **1 Scope**

This part of CISPR 16 deals with statistical considerations in the determination of EMC compliance of mass-produced products.

The reasons for such statistical considerations are:

- a) that the abatement of interference aims that the majority of the appliances to be approved shall not cause interference;
- b) that the CISPR limits should be suitable for the purpose of type approval of mass-produced appliances as well as approval of single-produced appliances;
- c) that to ensure compliance of mass-produced appliances with the CISPR limits, statistical techniques have to be applied;
- d) that it is important for international trade that the limits shall be interpreted in the same way in every country;
- e) that the National Committees of the IEC which collaborate in the work of the CISPR should seek to secure the agreement of the competent authorities in their countries.

Therefore, this part of CISPR 16 specifies requirements and provides guidance based on statistical techniques. EMC compliance of mass-produced appliances should be based on the application of statistical techniques that must reassure the consumer, with an 80 % degree of confidence, that 80 % of the appliances of a type being investigated comply with the emission or immunity requirements. Clause 4 gives some general requirements for this so-called 80 %/80 % rule. Clause 5 gives more specific requirements for the application of the 80 %/80 % rule to emission tests. Clause 6 gives guidance on the application of the CISPR 80 %/80 % rule to immunity tests. The 80 %/80 % rule protects the consumer from non-compliant appliances, but it says hardly anything about the probability that a batch of appliances from which the sample has been taken will be accepted. This acceptance probability is very important to the manufacturer. In Annex A, more information is given on acceptance probability (manufacturer's risk).

## **2 Normative references**

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161:1990, *International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility*  
Amendment 1 (1997)  
Amendment 2 (1998)

CISPR 16-4-2, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements*